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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/053,496	11/09/2001	Fong Piau	FLEX1814	3412
7590	03/16/2004		EXAMINER	
PENINSULA IP GROUP 2290 North First Street, Suite 101 San Jose, CA 95131			INOA, MIDYS	
		ART UNIT	PAPER NUMBER	
		2188		

DATE MAILED: 03/16/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Examiner-Initiated Interview Summary	Application No.	Applicant(s)
	10/053,496	PIAU ET AL.
	Examiner Midys Inoa	Art Unit 2188

All Participants: _____ **Status of Application:** _____

(1) Midys Inoa. (3) _____.

(2) Douglas H. Chaikin (#29140). (4) _____.

Date of Interview: 4 March 2004 **Time:** 3:00 PM

Type of Interview:

- Telephonic
 Video Conference
 Personal (Copy given to: Applicant Applicant's representative)

Exhibit Shown or Demonstrated: Yes No

If Yes, provide a brief description: _____

Part I.

Rejection(s) discussed:

none

Claims discussed:

none

Prior art documents discussed:

none

Part II.

SUBSTANCE OF INTERVIEW DESCRIBING THE GENERAL NATURE OF WHAT WAS DISCUSSED:

Applicant was informed that the RCE filed on Feb. 18th, 2004 was improper since no submission was filed with it. The examiner requested that a new RCE be submitted via fax in addition to an amendment.

Part III.

- It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview directly resulted in the allowance of the application. The examiner will provide a written summary of the substance of the interview in the Notice of Allowability.
 It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview did not result in resolution of all issues. A brief summary by the examiner appears in Part II above.

Midys Inoa
 (Examiner/SPE Signature)

(Applicant/Applicant's Representative Signature – if appropriate)